Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10075471	AYARS ET AL.	
Examiner	Art Unit	
Paliwal, Yogesh	2435	

SEARCHED

Class	Subclass	Date	Examiner
380	201	5/23/07	PWK
713	165, 194	5/23/07	PWK
705	57	5/23/07	PWK
713	153, 157, 166	11/6/07	PWK
713	194	8/12/2009	YP

SEARCH NOTES

Search Notes	Date	Examiner
380/210 and (digital with content with type)	5/23/07	PWK
IEEE	11/6/07	PWK
East text search	11/6/07	PWK
Inventor name search in East	6/18/2008	YP
(713/189,194,150,155,156,157,168,175,177) + Keywords- see search	6/18/2008	YP
history printout		
(726/2,16,17,20,26,27) + keywords- see search history printout	6/18/2008	YP
(380/200,201,210) + keywords - see search history printout	6/18/2008	YP
(705/59) + keywords- see search history prinout	6/18/2008	YP
Databse search: Google- see search history prinout	6/18/2008	YP
Update (713/189,194,150,155,156,157,168,175,177) + Keywords- see	1/3/2009	YP
search history printout		
Update (726/2,16,17,20,26,27) + keywords- see search history printout	1/3/2009	YP
Update (380/200,201,210) + keywords - see search history printout	1/3/2009	YP
Update (705/59) + keywords- see search history prinout	1/3/2009	YP
Update (713/189,194,150,155,156,157,168,175,177) + Keywords- see	1/3/2009	YP
search history printout		
Update (726/2,16,17,20,26,27) + keywords- see search history printout	8/12/2009	YP
Update (380/200,201,210) + keywords - see search history printout	8/12/2009	YP
Update (705/59) + keywords- see search history prinout	8/12/2009	YP
NPL Database: Google Scholar	8/12/2009	YP
Consulted with Ponnoreay Pich regarding 101 rejection for claims 29-33.	8/5/2009	YP
Consulted with Ponnoreay Pich for allowable subject matter	6/4/2009	YP
Consulted with Kim Vu for allowable subject matter	6/4/2009	YP

U.S. Patent and Trademark Office Part of Paper No.: 20090812

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	(digital adj content adj rendering adj module with	8/13/2009	YP
	hierarchy with tamper with digital adj content).clm.		

U.S. Patent and Trademark Office Part of Paper No. : 20090812